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#### Report Template Revision Date: Mar.1st, 2017

Report Template Version: V03

# **RF Exposure Evaluation Report**

Report No.: CQASZ20190500383E-02

Applicant: Shenzhen heng shang pin technology co., LTD

**Address of Applicant:** 4004 Hao Wuhedadao Bantianjiedao Longgangqu, Shenzhen, China

Manufacturer: Shenzhen heng shang pin technology co., LTD

Address of Manufacturer: 4004 Hao Wuhedadao Bantianjiedao Longgangqu, Shenzhen, China

**Factory:** Shenzhen heng shang pin technology co., LTD

Address of Factory: 4004 Hao Wuhedadao Bantianjiedao Longganggu, Shenzhen, China

**Equipment Under Test (EUT):** 

**Brand Name:** 

Tested By:

**Product:** Bluetooth Headset

All Model No.: HSP-B5, HSP-B6, HSP-B6-PRO, HSP-B7, HSP-B11

HonShoop

**Test Model No.:** HSP-B5

2ALXX-HSP-BX FCC ID: 47 CFR Part 1.1307 Standards:

47 CFR Part 2.1093

KDB447498D01 General RF Exposure Guidance v06

Date of Test: 2019-05-29 to 2019-06-03

Date of Issue: 2019-06-03 PASS\*

Test Result:

(Daisy Qin)

Reviewed By:

Aaron Ma )

Approved By:



The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CQA, this report can't be reproduced except in full.

<sup>\*</sup> In the configuration tested, the EUT complied with the standards specified above.



Report No.: CQASZ20190500383E-02

# 1 Version

## **Revision History Of Report**

Report No.	Version	Description	Issue Date
CQASZ20190500383E-02	Rev.01	Initial report	2019-06-03





Report No.: CQASZ20190500383E-02

## 2 Contents

			Page
1	VERSI	ON	2
2		ENTS	
3	GENER	RAL INFORMATION	4
	3.1 CLIE	NT INFORMATION	4
	3.2 Geni	ERAL DESCRIPTION OF EUT	4
4	SAR E	VALUATION	5
	4.1 RF E	Exposure Compliance Requirement	5
	4.1.1	Standard Requirement	5
	4.1.2	Limits	5
	4.1.3	EUT RF Exposure	6



Report No.: CQASZ20190500383E-02

## 3 General Information

### 3.1 Client Information

Applicant:	Shenzhen heng shang pin technology co., LTD
Address of Applicant:	4004 Hao Wuhedadao Bantianjiedao Longgangqu, Shenzhen, China
Manufacturer:	Shenzhen heng shang pin technology co., LTD
Address of Manufacturer:	4004 Hao Wuhedadao Bantianjiedao Longgangqu, Shenzhen, China
Factory:	Shenzhen heng shang pin technology co., LTD
Address of Factory:	4004 Hao Wuhedadao Bantianjiedao Longgangqu, Shenzhen, China

# 3.2 General Description of EUT

Product Name:	Bluetooth Headset
All Model No.:	HSP-B5, HSP-B6, HSP-B6-PRO, HSP-B7, HSP-B11
Test Model No.:	HSP-B5
Trade Mark:	HonShoop
Hardware Version:	V0.5
Software Version:	V0.1
Operation Frequency:	2402MHz~2480MHz
Bluetooth Version:	V5.0
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Transfer Rate:	1Mbps/2Mbps/3Mbps
Number of Channel:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Product Type:	☐ Mobile ☐ Portable ☐ Fix Location
Test Software of EUT:	Blue Test3 (manufacturer declare )
Antenna Type:	Ceramic antenna
Antenna Gain:	0dBi
Power Supply:	lithium battery:DC3.7V, Charge by DC5.0V

Note:

All model: HSP-B5, HSP-B6, HSP-B6-PRO, HSP-B7, HSP-B11

Only the model HSP-B5 was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, with difference being color of appearance and model name.



Report No.: CQASZ20190500383E-02

#### 4 SAR Evaluation

## 4.1 RF Exposure Compliance Requirement

#### 4.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

#### **4.1.2 Limits**

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and $\le 7.5$ for 10-g extremity SAR, where
☐ f(GHz) is the RF channel transmit frequency in GHz ☐ Power and distance are rounded to the nearest mW and mm before calculation 17 ☐ The result is rounded to one decimal place for comparison The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation
distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion





Report No.: CQASZ20190500383E-02

### 4.1.3 EUT RF Exposure

#### **Measurement Data**

Measurement Data					
	GFSK	mode			
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	0.420	0±1	1.0	1.259	
Middle(2441MHz)	2.190	1.5±1	2.5	1.778	
Highest(2480MHz)	3.500	3.0±1	4.0	2.512	
	π/4DQPS	SK mode			
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	-1.010	-2.0±1	-1.0	0.794	
Middle(2441MHz)	1.590	1.0±1	2.0	1.585	
Highest(2480MHz)	2.930	2.0±1	3.0	1.995	
	8DPSK	mode			
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	-0.780	-2.0±1	-1.0	0.794	
Middle(2441MHz)	1.680	1.0±1	2.0	1.585	
Highest(2480MHz)	3.020	2.5±1	3.5	2.239	

	Maximum	<b>-</b>		ım tune-	Calculated value	Exclusion threshold
Channel	Peak	Tune up	up P	ower		
	Conducted Output Power (dBm)	tolerance (dBm)	(dBm)	(mW)		
Lowest (2402MHz)	0.420	0±1	1.0	1.259	0.39	
Middle (2441MHz)	2.190	1.5±1	2.5	1.778	0.56	3.0
Highest (2480MHz)	3.500	3.0±1	4.0	2.512	0.79	

Remark: The Max Conducted Peak Output Power data refer to report Report No.: CQASZ20190500383E-01